

DEC 8 2001 U.S. PATENT & TRADEMARK OFFICE APPLICANT'S PART CITATION (Use several sheets if necessary)	Application	09/887,189	OFGS File No.	P/2292-45 DIV
	Applicant	Seok-Keun KOH, et al.		
	Filing Date	Group Art Unit June 22, 2001 1741 1762		

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

WL	English translation of Abstract for Japanese Patent No. JP 5-179034 dated 07/20/93
Examiner 	Date Considered 4/15/01

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U.S. PATENT DOCUMENTS						
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
<i>JK</i>	US-5,549,935	08-1996	Nguyen, et al.			01/04/95
	US-4,988,573	01-1991	Nakayama, et al.			07/18/89
<i>JK</i>	US-4,598,022	07-1986	Haque, et al.			03/04/85
<i>JK</i>	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
	US-					
FOREIGN PATENT DOCUMENTS						
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation
						Yes
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
Examiner	<i>JK</i>					Date Considered <i>4/15/01</i>
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